

Search Notes

Application/Control No.

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Examiner

Ryan Lepisto

Applicant(s)/Patent under
Reexamination

TANAKA ET AL.

Art Unit

2883

SEARCHED

Class	Subclass	Date	Examiner
385	75	8/15/2006	RAL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
385	75	8/15/2006	RAL
See interference search printouts		8/15/2006	RAL

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See search printouts - EAST (all databases), PALM (inventorship), non- patent literature (IEEE, INSPEC)	8/15/2006	RAL
Consulted Frank Font on allowability <i>FF</i>	8/15/06	RAL